

MOS FIELD EFFECT TRANSISTOR 2SK3109

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK3109 is N channel MOS FET device that features a low on-state resistance and excellent switching characteristics, and designed for high voltage applications such as DC/DC converter.

FEATURES

- Gate voltage rating ±30 V
- Low on-state resistance $R_{\text{DS(on)}} = 0.4 \ \Omega \ \text{MAX}. \ (\text{V}_{\text{GS}} = 10 \ \text{V}, \ \text{I}_{\text{D}} = 5.0 \ \text{A})$
- Low input capacitance C_{iss} = 400 pF TYP. (V_{DS} = 10 V, V_{GS} = 0 V)
- Avalanche capability rated
- Built-in gate protection diode
- Surface mount device available

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

VDSS	200	V
Vgss	±30	V
D(DC)	±10	Α
D(pulse)	±30	Α
P _{T1}	1.5	W
PT2	50	W
Tch	150	°C
Tstg	–55 to +150	°C
las	10	Α
Eas	35	mJ
	VGSS ID(DC) ID(pulse) PT1 PT2 Tch Tstg IAS	VGSS ±30 ID(DC) ±10 ID(pulse) ±30 PT1 1.5 PT2 50 Tch 150 Tstg -55 to +150 IAS 10

Notes 1. PW \leq 10 μ s, Duty Cycle \leq 1 %

2. Starting T_{ch} = 25 °C, V_{DD} = 100 V, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0 V

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The mark \star shows major revised points.

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ORDERING INFORMATION

PART NUMBER	PACKAGE		
2SK3109	TO-220AB		
2SK3109-S	TO-262		
2SK3109-ZJ	TO-263		

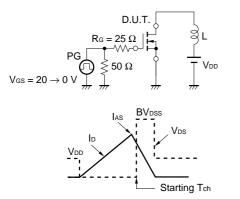
10 %

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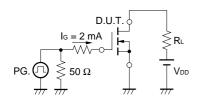
	Characteristics	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
	Drain Leakage Current	IDSS	Vds = 200 V, Vgs = 0 V			100	μA
	Gate Leakage Current	Igss	$V_{GS} = \pm 30 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
	Gate to Source Cut-off Voltage	V _{GS(off)}	Vbs = 10 V, lb = 1 mA	2.5		4.5	V
	Forward Transfer Admittance	yfs	Vds = 10 V, Id = 5.0 A	1.5			S
	Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 5.0 A		0.32	0.4	Ω
	Input Capacitance	Ciss	Vps = 10 V		400		pF
	Output Capacitance	Coss	Vgs = 0 V		110		pF
	Reverse Transfer Capacitance	Crss	f = 1 MHz		55		pF
	Turn-on Delay Time	td(on)	Vdd = 100 V		12		ns
	Rise Time	tr	ID = 5.0 A		34		ns
	Turn-off Delay Time	td(off)	$V_{GS(on)} = 10 V$		40		ns
	Fall Time	tr	R _G = 10 Ω		20		ns
\star	Total Gate Charge	QG	Vdd = 160 V		18		nC
	Gate to Source Charge	QGS	Vgs = 10 V		3.5		nC
	Gate to Drain Charge	QGD	I _D = 10 A		10		nC
	Diode Forward Voltage	VF(S-D)	IF = 10 A, VGS = 0 V		1.0		V
	Reverse Recovery Time	trr	IF = 10 A, Vgs = 0 V		250		ns
	Reverse Recovery Charge	Qrr	di/dt = 50 A/µs		1.0		μC

ELECTRICAL CHARACTERISTICS (TA = 25 °C)

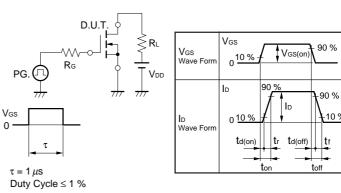
TEST CIRCUIT 1 AVALANCHE CAPABILITY



TEST CIRCUIT 3 GATE CHARGE

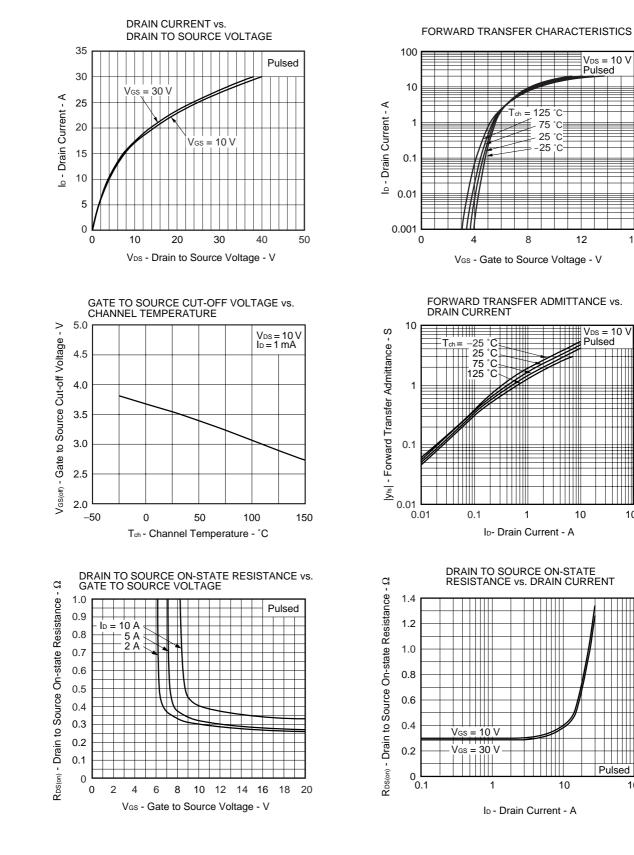


TEST CIRCUIT 2 SWITCHING TIME



16

100

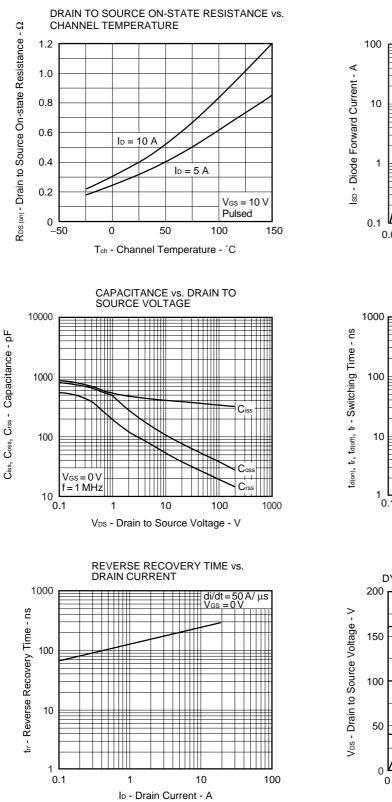


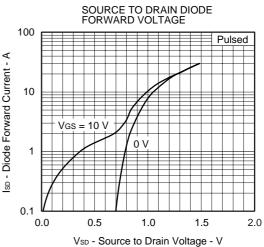
TYPICAL CHARACTERISTICS (TA = 25 °C) ★

Data Sheet D13332EJ1V0DS00

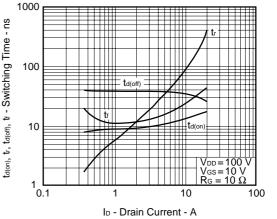
Pulsed

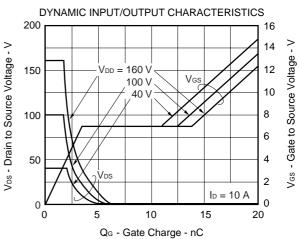
100



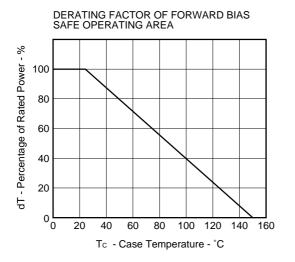


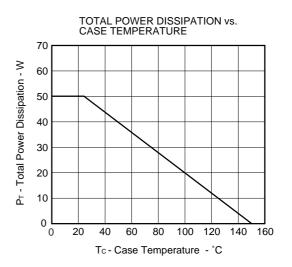
SWITCHING CHARACTERISTICS



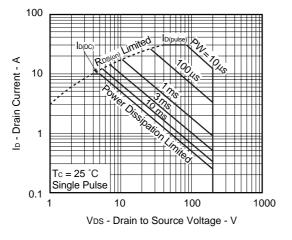


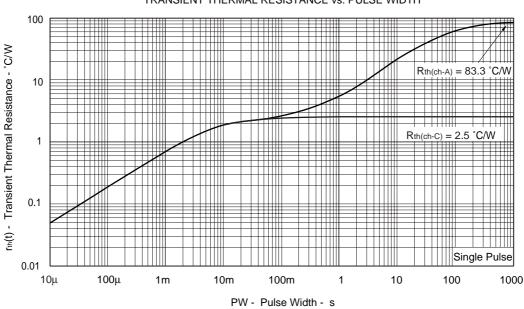
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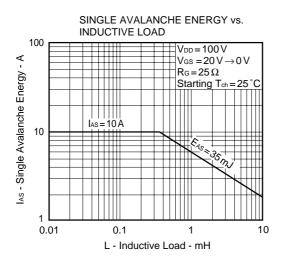
FORWARD BIAS SAFE OPERATING AREA

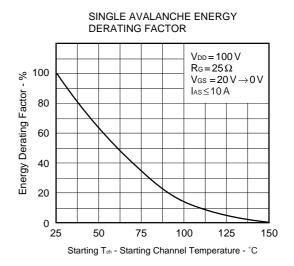




TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

Data Sheet D13332EJ1V0DS00





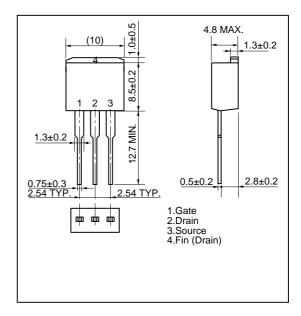
Data Sheet D13332EJ1V0DS00

PACKAGE DRAWINGS (Unit : mm)

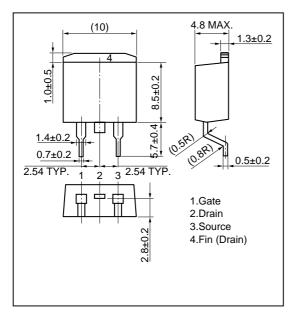
1)TO-220AB (MP-25)

4.8 MAX. 10.6 MAX. 3.0±0.3 Ø3.6±0.2 1.3±0.2 10.0 MIN $\langle \mathcal{E} \rangle$.5 MAX 5.9 4 15. 2 3 1 6.0 MAX. 12.7 MIN. <u>1.3±</u>0.2 0.75±0.1 0.5±0.2 2.8±0.2 2.54 TYP 2.54 TYP. 1.Gate 2.Drain 3.Source 4.Fin (Drain) 中中中

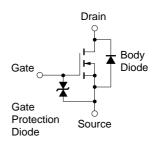
2)TO-262 (MP-25 Fin Cut)



3)TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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